

Automotive-grade N-channel 60 V, 2.3 mΩ typ., 180 A STripFET™ F6 Power MOSFET in a TO-220 package

Datasheet - production data

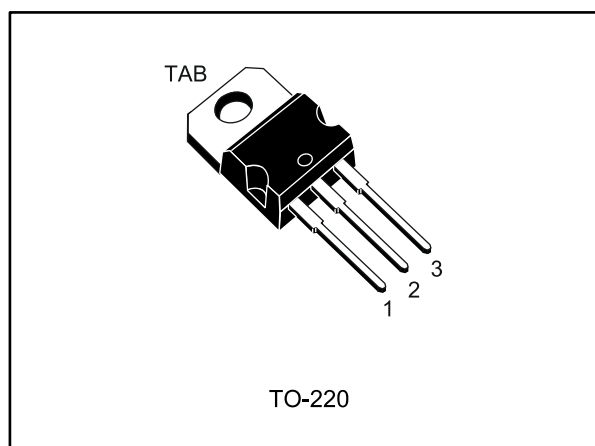


Figure 1: Internal schematic diagram

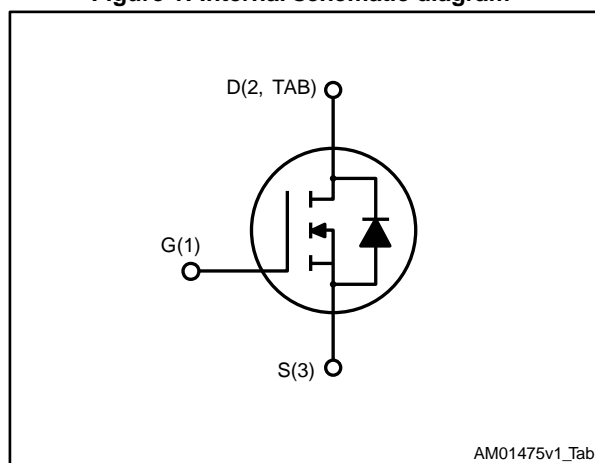


Table 1: Device summary

| Order code | Marking | Package | Packing |
|--------------|---------|---------|---------|
| STP265N6F6AG | 265N6F6 | TO-220 | Tube |

Features

| Order code | V _{DS} | R _{DS(on)} max | I _D |
|--------------|-----------------|-------------------------|----------------|
| STP265N6F6AG | 60 V | 2.85 mΩ | 180 A |

- AEC-Q101 qualified
- Very low on-resistance
- Very low gate charge
- High avalanche ruggedness
- Low gate drive power loss



Applications

- Switching applications

Description

This device is an N-channel Power MOSFET developed using the STripFET™ F6 technology with a new trench gate structure. The resulting Power MOSFET exhibits very low R_{DS(on)} in all packages.

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1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|--|-------------|--------------------|
| V_{DS} | Drain-source voltage | 60 | V |
| V_{GS} | Gate-source voltage | ± 20 | V |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 25\text{ }^{\circ}\text{C}$ | 180 | A |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 100\text{ }^{\circ}\text{C}$ | 180 | A |
| $I_{DM}^{(2)}$ | Drain current (pulsed) | 720 | A |
| P_{TOT} | Total dissipation at $T_C = 25\text{ }^{\circ}\text{C}$ | 300 | W |
| E_{AS} | Single pulse avalanche energy (Starting $T_J = 25\text{ }^{\circ}\text{C}$, $I_D = 80\text{ A}$) | 720 | mJ |
| T_{stg} | Storage temperature range | - 55 to 175 | $^{\circ}\text{C}$ |
| T_J | Operating junction temperature range | | |

Notes:

(1) Current limited by package.

(2) Pulse width limited by safe operating area.

Table 3: Thermal data

| Symbol | Parameter | Value | Unit |
|----------------|--------------------------------------|-------|----------------------|
| $R_{thj-case}$ | Thermal resistance junction-case max | 0.5 | $^{\circ}\text{C/W}$ |
| $R_{thj-amb}$ | Thermal resistance junction-amb max | 62.5 | $^{\circ}\text{C/W}$ |

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 4: On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------------|-----------------------------------|--|------|------|-------|------|
| V _{(BR)DSS} | Drain-source breakdown voltage | I _D = 250 µA, V _{GS} = 0 V | 60 | | | V |
| I _{DSS} | Zero gate voltage drain current | V _{DS} = 60 V, V _{GS} = 0 V | | | 1 | µA |
| | | V _{DS} = 60 V, T _C = 125 °C ⁽¹⁾ V _{GS} = 0 V | | | 100 | µA |
| I _{GSS} | Gate-body leakage current | V _{GS} = ± 20 V, V _{DS} = 0 V | | | ± 100 | nA |
| V _{GS(th)} | Gate threshold voltage | V _{DS} = V _{GS} , I _D = 250 µA | 2 | | 4 | V |
| R _{DS(on)} | Static drain-source on-resistance | V _{GS} = 10 V, I _D = 60 A | | 2.3 | 2.85 | mΩ |

Notes:

⁽¹⁾Defined by design, not subject to production test.

Table 5: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|------------------|------------------------------|---|------|-------|------|------|
| C _{iss} | Input capacitance | V _{DS} = 25 V, f = 1 MHz, V _{GS} = 0 V | - | 11800 | - | pF |
| C _{oss} | Output capacitance | | - | 1235 | - | pF |
| C _{rss} | Reverse transfer capacitance | | - | 488 | - | pF |
| Q _g | Total gate charge | V _{DD} = 30 V, I _D = 120 A, V _{GS} = 10 V (see Figure 14: "Test circuit for gate charge behavior") | - | 183 | - | nC |
| Q _{gs} | Gate-source charge | | - | 53 | - | nC |
| Q _{gd} | Gate-drain charge | | - | 41 | - | nC |

Table 6: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------------|---------------------|---|------|------|------|------|
| t _{d(on)} | Turn-on delay time | V _{DD} = 30 V, I _D = 60 A R _G = 4.7 Ω, V _{GS} = 10 V (see Figure 13: "Test circuit for resistive load switching times" and Figure 18: "Switching time waveform") | - | 31 | - | ns |
| t _r | Rise time | | - | 165 | - | ns |
| t _{d(off)} | Turn-off-delay time | | - | 144 | - | ns |
| t _f | Fall time | | - | 63 | - | ns |

Table 7: Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|--|------|------|------|------|
| I_{SD} | Source-drain current | | | | 180 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | | | 720 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 180\text{ A}$, $V_{GS} = 0\text{ V}$ | | | 1.1 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 120\text{ A}$, $V_{DD} = 48\text{ V}$ $di/dt = 100\text{ A}/\mu\text{s}$, $T_j = 150\text{ }^{\circ}\text{C}$ (see Figure 15: "Test circuit for inductive load switching and diode recovery times") | - | 56 | - | ns |
| Q_{rr} | Reverse recovery charge | | - | 116 | - | nC |
| I_{RRM} | Reverse recovery current | | - | 3.8 | - | A |

Notes:

⁽¹⁾ Pulse width limited by safe operating area.

⁽²⁾ Pulsed: pulse duration = 300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2: Safe operating area

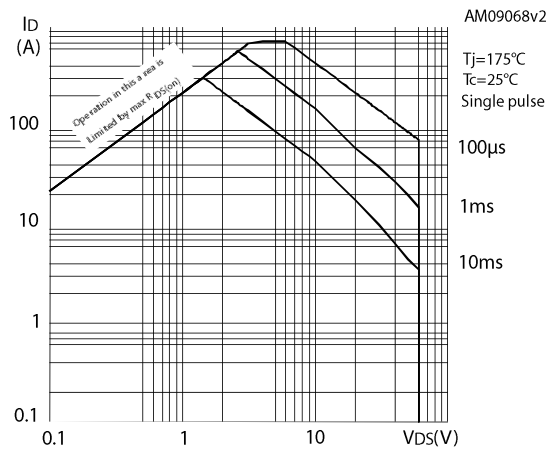


Figure 3: Thermal impedance

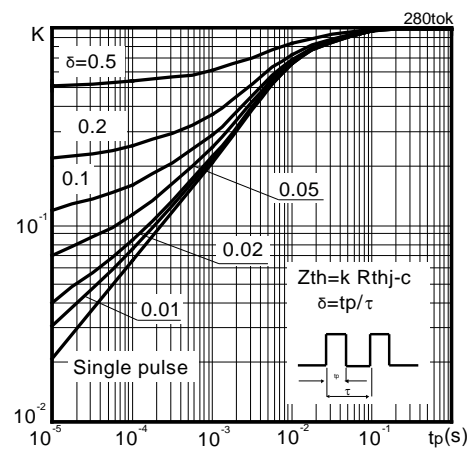


Figure 4: Output characteristics

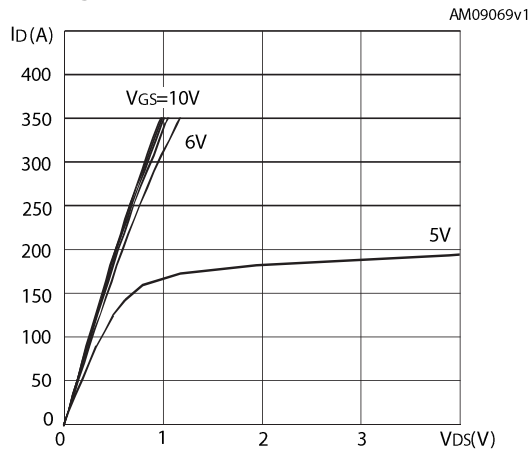


Figure 5: Transfer characteristics

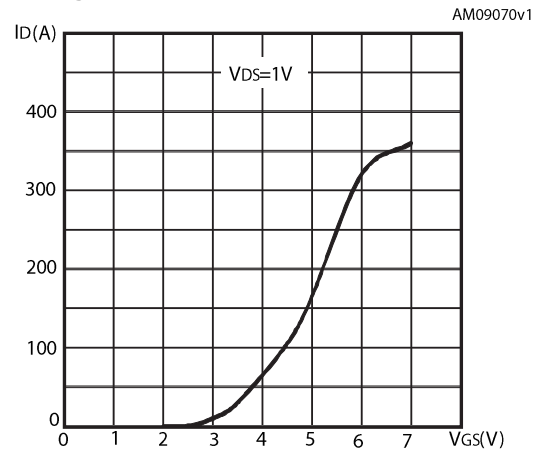


Figure 6: Normalized V(BR)DSS vs. temperature

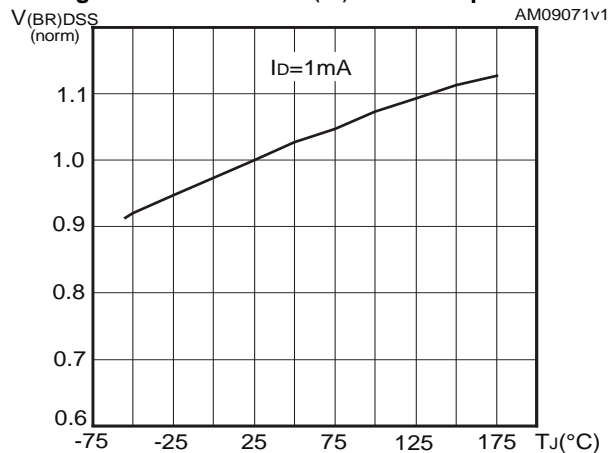


Figure 7: Static drain-source on-resistance

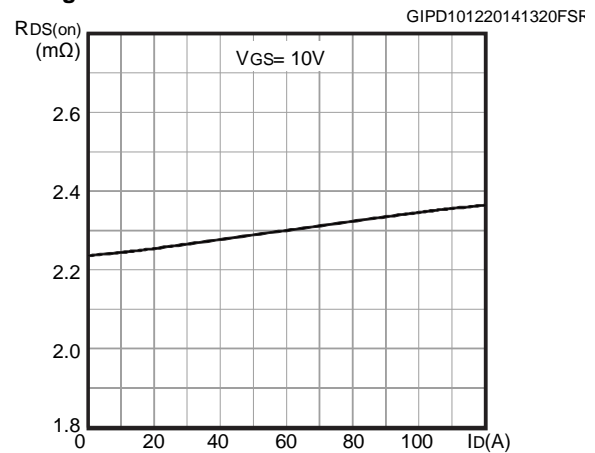


Figure 8: Gate charge vs. gate-source voltage

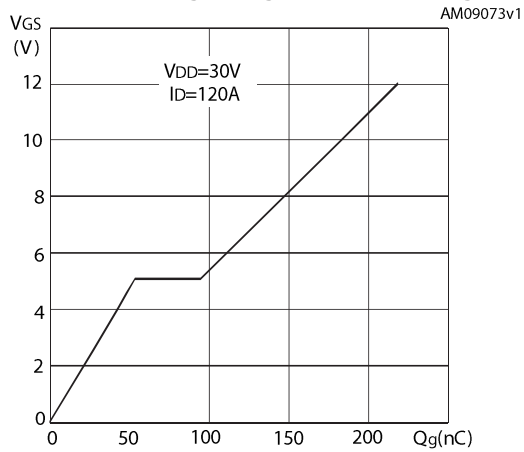


Figure 9: Capacitance variations

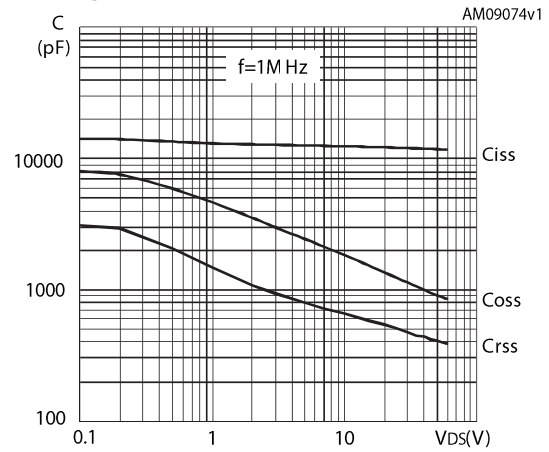


Figure 10: Normalized gate threshold voltage vs. temperature

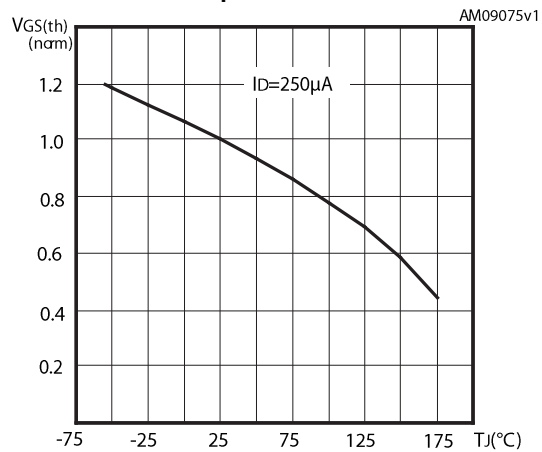


Figure 11: Normalized on resistance vs. temperature

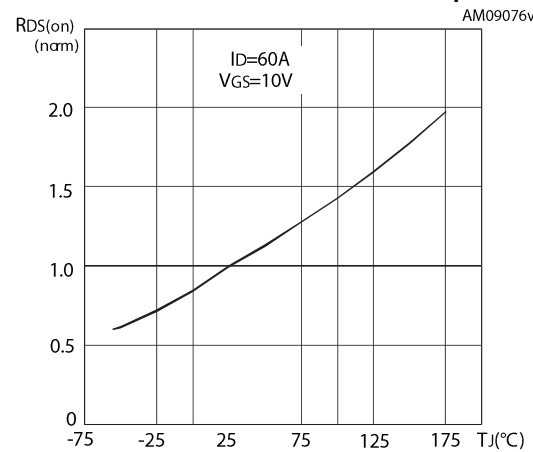
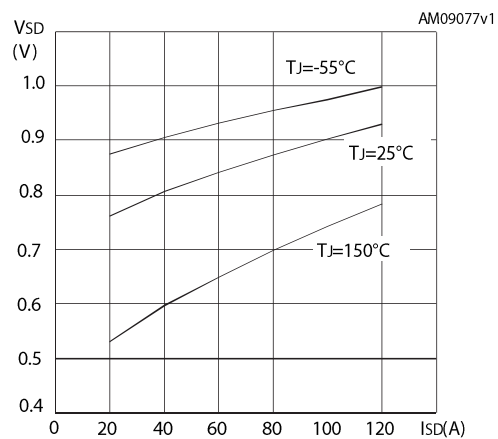
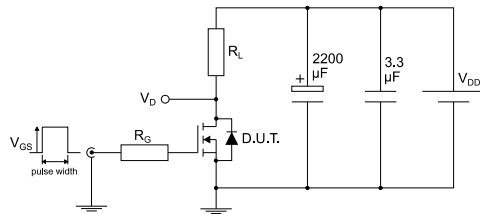


Figure 12: Source-drain diode forward characteristics



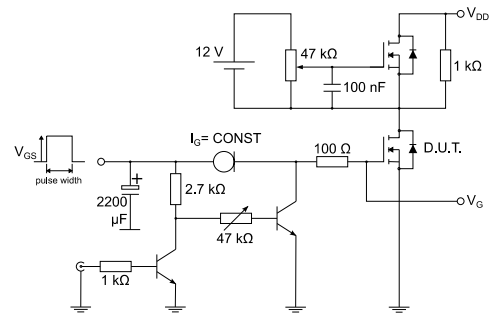
3 Test circuits

Figure 13: Test circuit for resistive load switching times



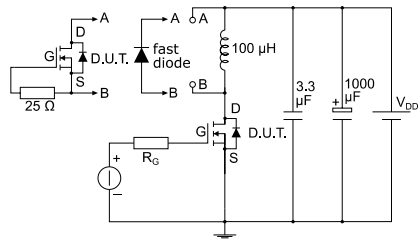
AM01468v1

Figure 14: Test circuit for gate charge behavior



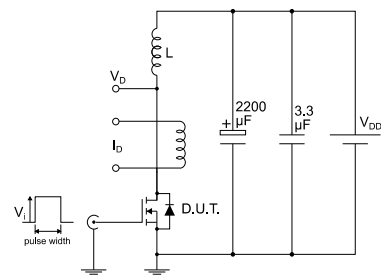
AM01469v1

Figure 15: Test circuit for inductive load switching and diode recovery times



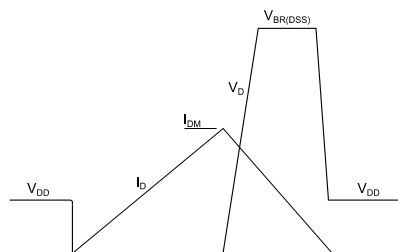
AM01470v1

Figure 16: Unclamped inductive load test circuit



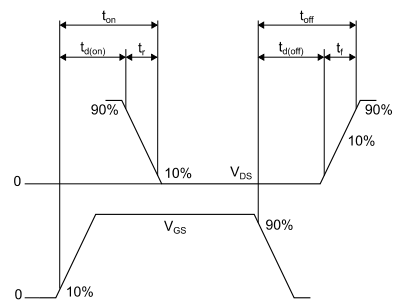
AM01471v1

Figure 17: Unclamped inductive waveform



AM01472v1

Figure 18: Switching time waveform



AM01473v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-220 mechanical data

Figure 19: TO-220 type A package outline

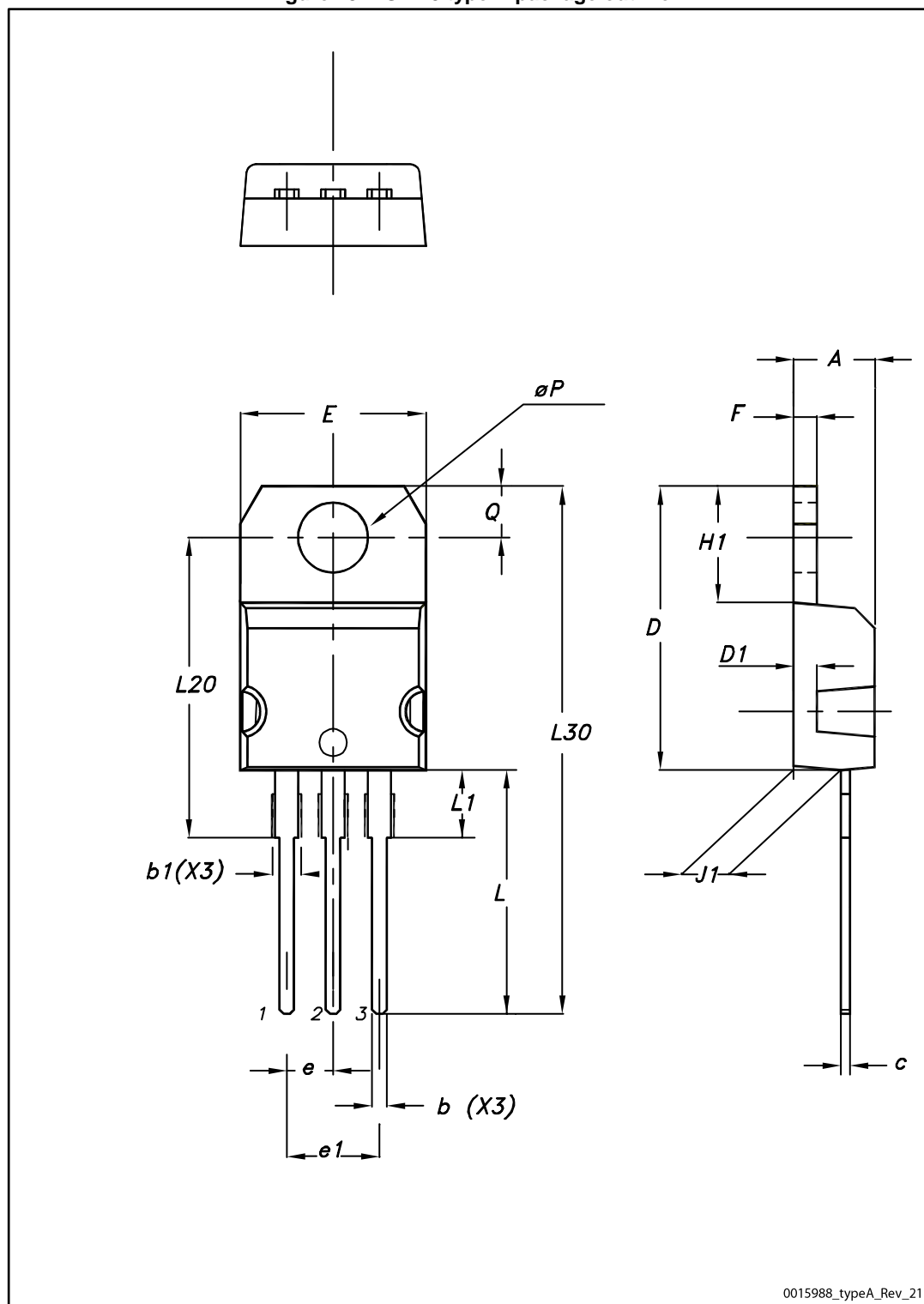


Table 8: TO-220 type A mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.40 | | 4.60 |
| b | 0.61 | | 0.88 |
| b1 | 1.14 | | 1.55 |
| c | 0.48 | | 0.70 |
| D | 15.25 | | 15.75 |
| D1 | | 1.27 | |
| E | 10.00 | | 10.40 |
| e | 2.40 | | 2.70 |
| e1 | 4.95 | | 5.15 |
| F | 1.23 | | 1.32 |
| H1 | 6.20 | | 6.60 |
| J1 | 2.40 | | 2.72 |
| L | 13.00 | | 14.00 |
| L1 | 3.50 | | 3.93 |
| L20 | | 16.40 | |
| L30 | | 28.90 | |
| øP | 3.75 | | 3.85 |
| Q | 2.65 | | 2.95 |

5 Revision history

Table 9: Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 10-Dec-2014 | 1 | First release. |
| 16-Dec-2014 | 2 | Document status promoted from preliminary to production data. |
| 16-Nov-2016 | 3 | The part number STW265N6F6AG has been moved to a separate datasheet. Updated title, cover image, features and description in cover page. Updated Table 1: "Device summary" , Table 3: "Thermal data" , Section 4: "Package information" . Minor text changes. |

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